

For a sunny future



***NCCAUS: Thin Film Applications and Equipment Solutions
for Photovoltaic Applications***

February 23, 2011



Discussion Overview

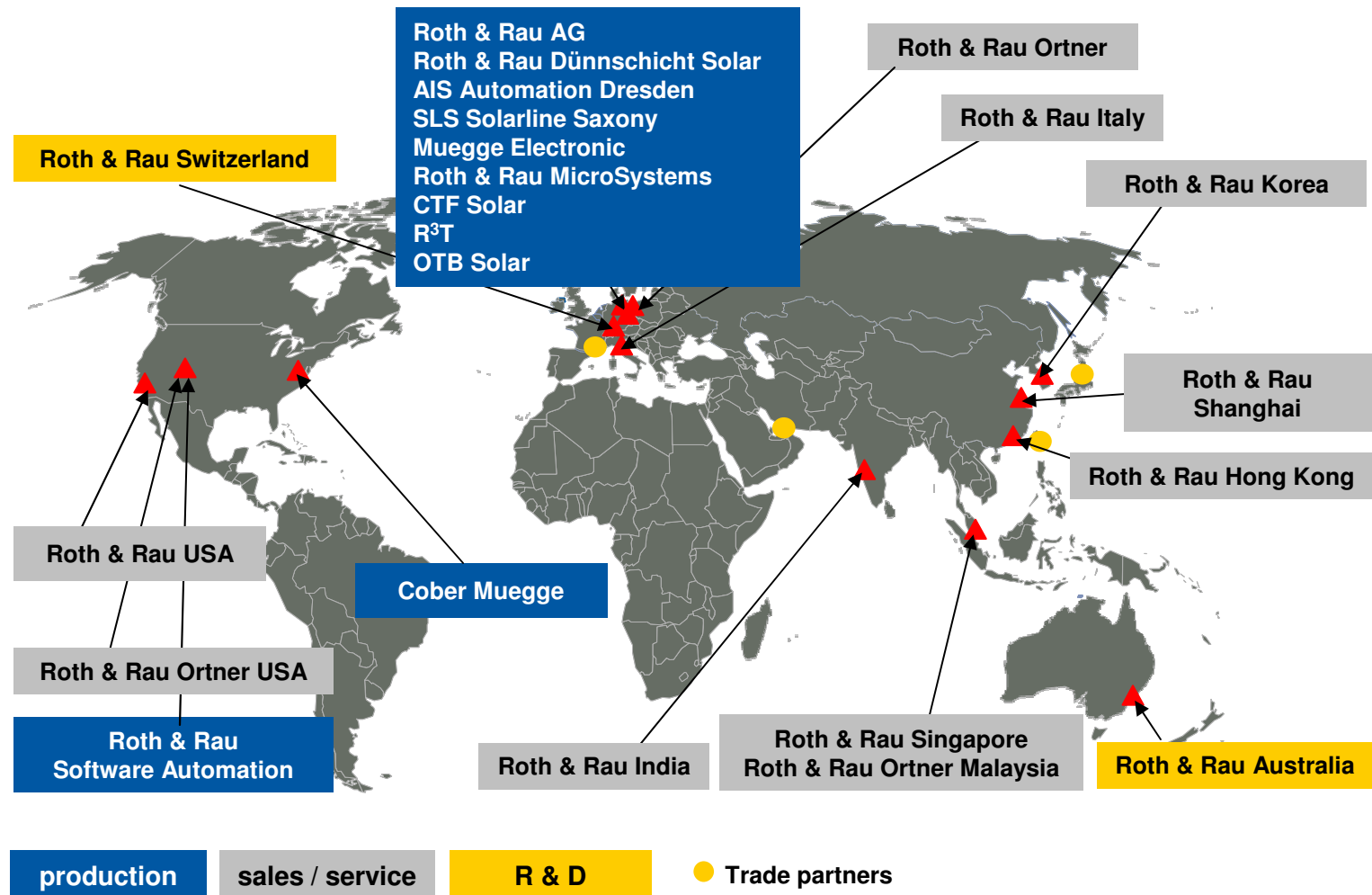
- Overview/ / Introduction Roth & Rau
- Product Introduction
- Applications & Cell Performance Benefits
- Process Discussion
- Conclusions / Questions

Roth & Rau at a glance

Segment	Leading supplier of equipment and technology for the photovoltaic industry and supplier of process systems based on plasma and ion beam technology for other sectors like the semiconductor and optical industry
Technological expertise	Comprehensive know how in development and application of plasma process equipment for surface treatment in various industrial sectors 10 years of experience with plasma technology in solar cell manufacturing
Founding year	1990
Management	Dr. Dietmar Roth (CEO, co-founder), Thomas Hengst (CSO), Paul Breddels (COO)
Location	Hohenstein-Ernstthal (headquarters)
Employees	1134 as of June 30, 2010
Listing	listed on Frankfurt Stock Exchange since May 2006, listed in TecDAX since June 2008
Shareholders	11,35% founders, 6,34% OTB Group B.V., 82,31% free float

International footprint

Introduction



**ROTH
&RAU**

Strong customer base in the PV industry



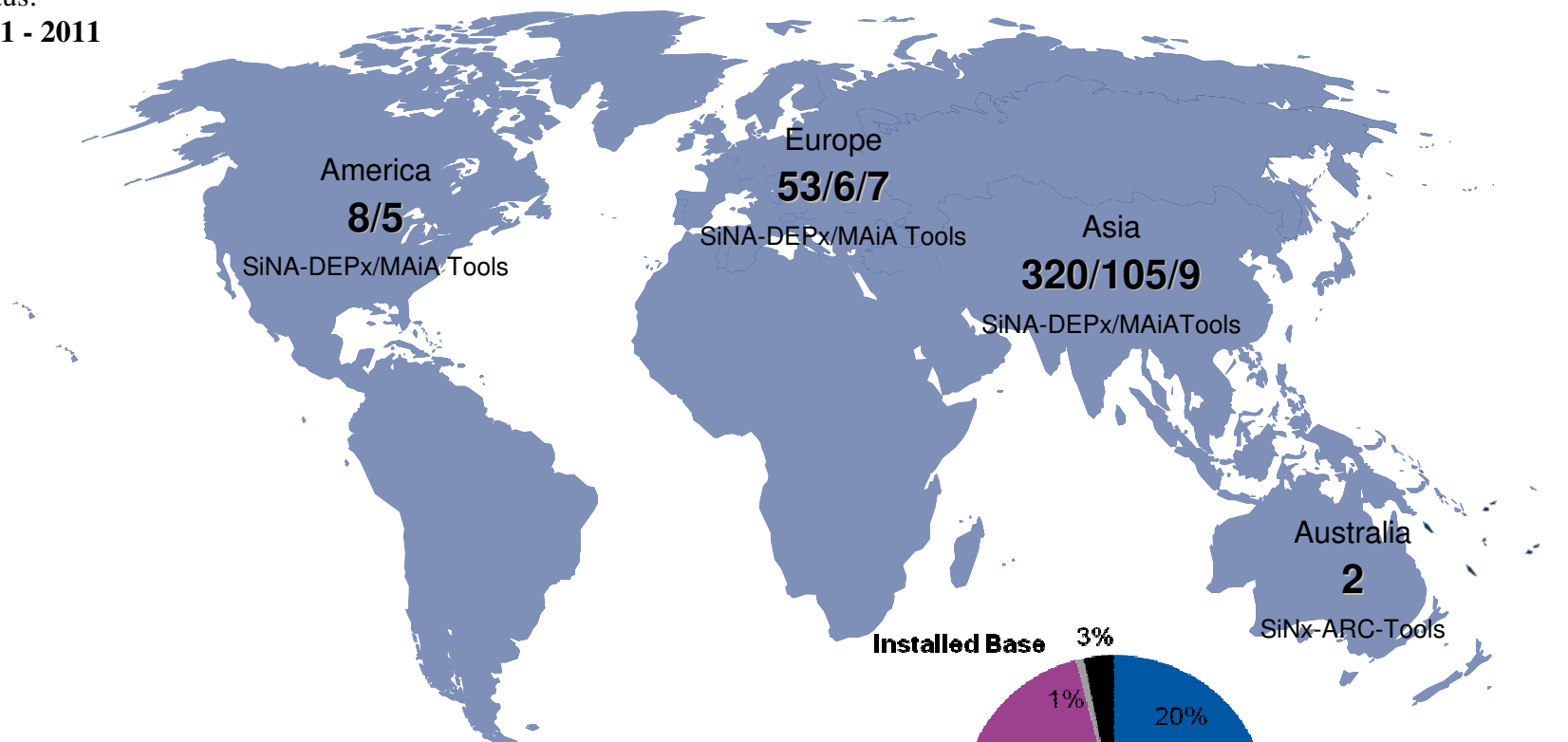
... and many others



**ROTH
& RAU**

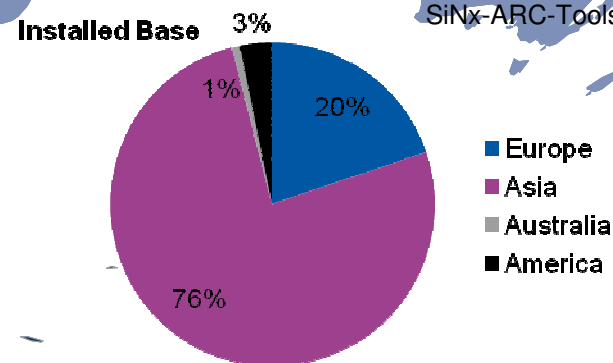
Installed Base SiNA® / DEP_x / MAiA

Status:
2001 - 2011



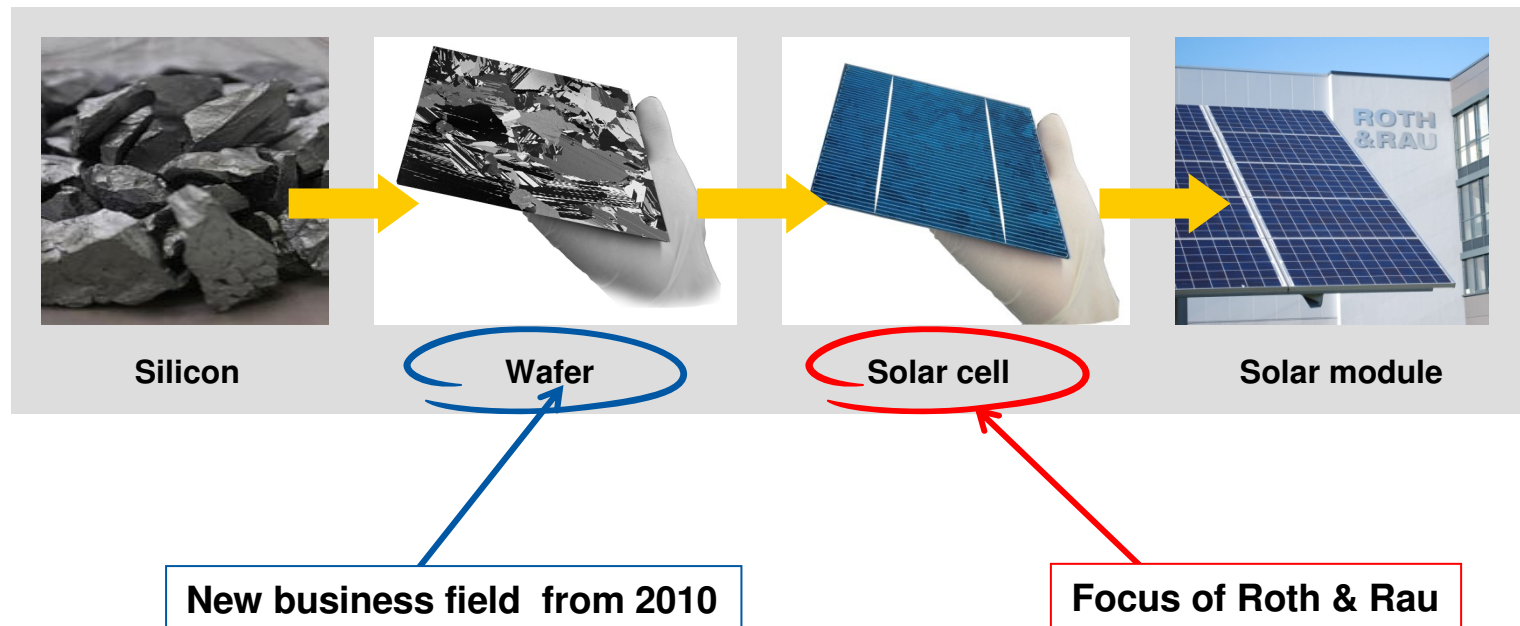
Total:

> 500 SiNA/DEPx/MAiA -Tools
 129 PV Solar cell makers in 21 Countries on 4 continents
 > 17 GW delivered theoretical PV power (70% already installed)



Products and technology for photovoltaic's

Value chain crystalline silicon solar module manufacturing



Products and technology for photovoltaic's

Single equipment



In-line PECVD/PVD equipment



diffusion and firing furnace



mc-Si crystallisation furnace

Turnkey solutions



crystalline Si solar cells



CdTe thin film solar
modules



mc- silicon wafers

AR coating equipment for c-Si solar cells

→ Key products of the Roth & Rau group

■ SiNA[®] / MAiA[®] by Roth & Rau AG

- Leading product in the market
- Equipment with the highest throughput in combination with excellent layer quality and low running costs
- From 2010 launch of new model with further cost advantages and possible applications for the production of new types of solar cell (e.g. with rear side passivation)

SiNA[®]

■ DEP_x by OTB

- Most compact in-line equipment with high deposition speed
- well suited for small to mid-scale production

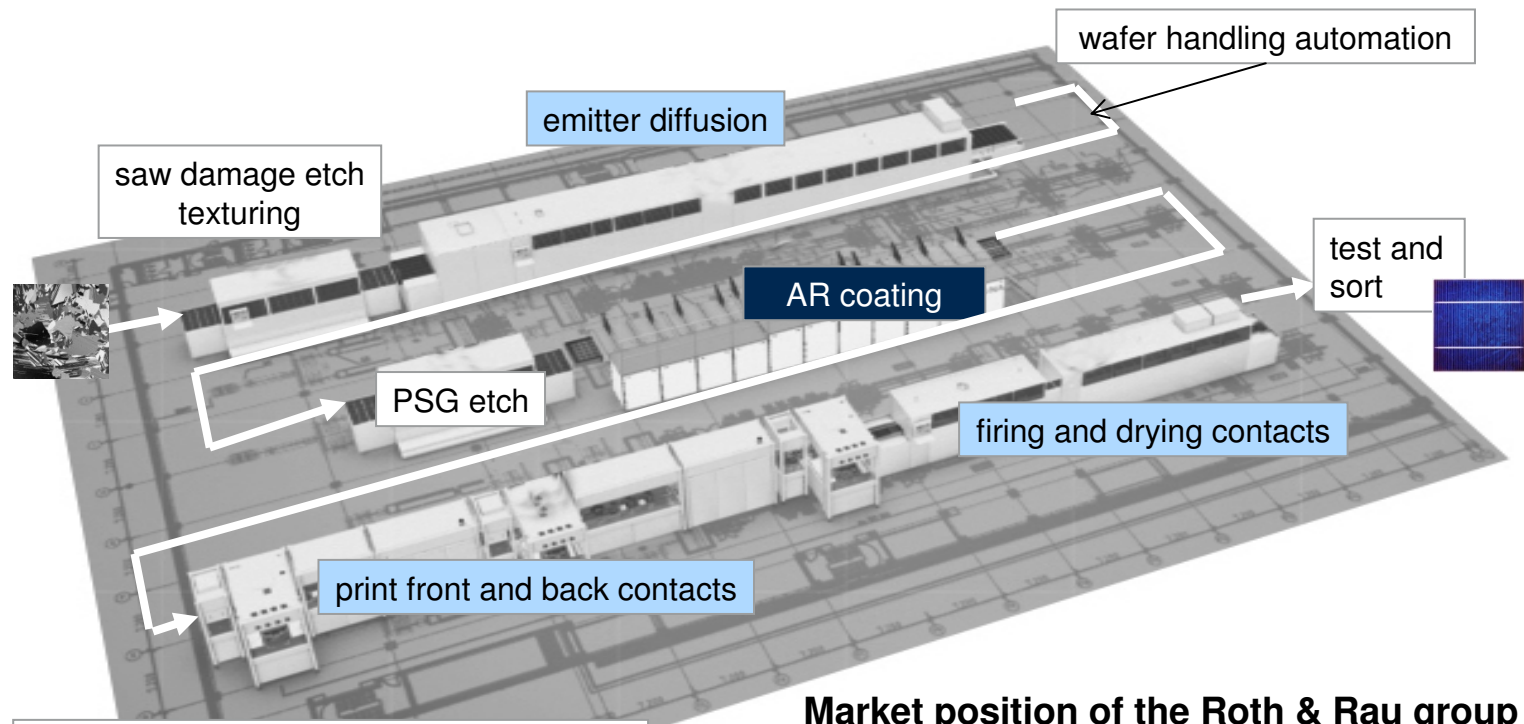
■ Next generation:

- Development has already started
- Goal: modular equipment for several application combining the advantages of both systems

DEP_x

Products and technology for photovoltaic's

Standard crystalline silicon solar cell production process



Over the whole production process:

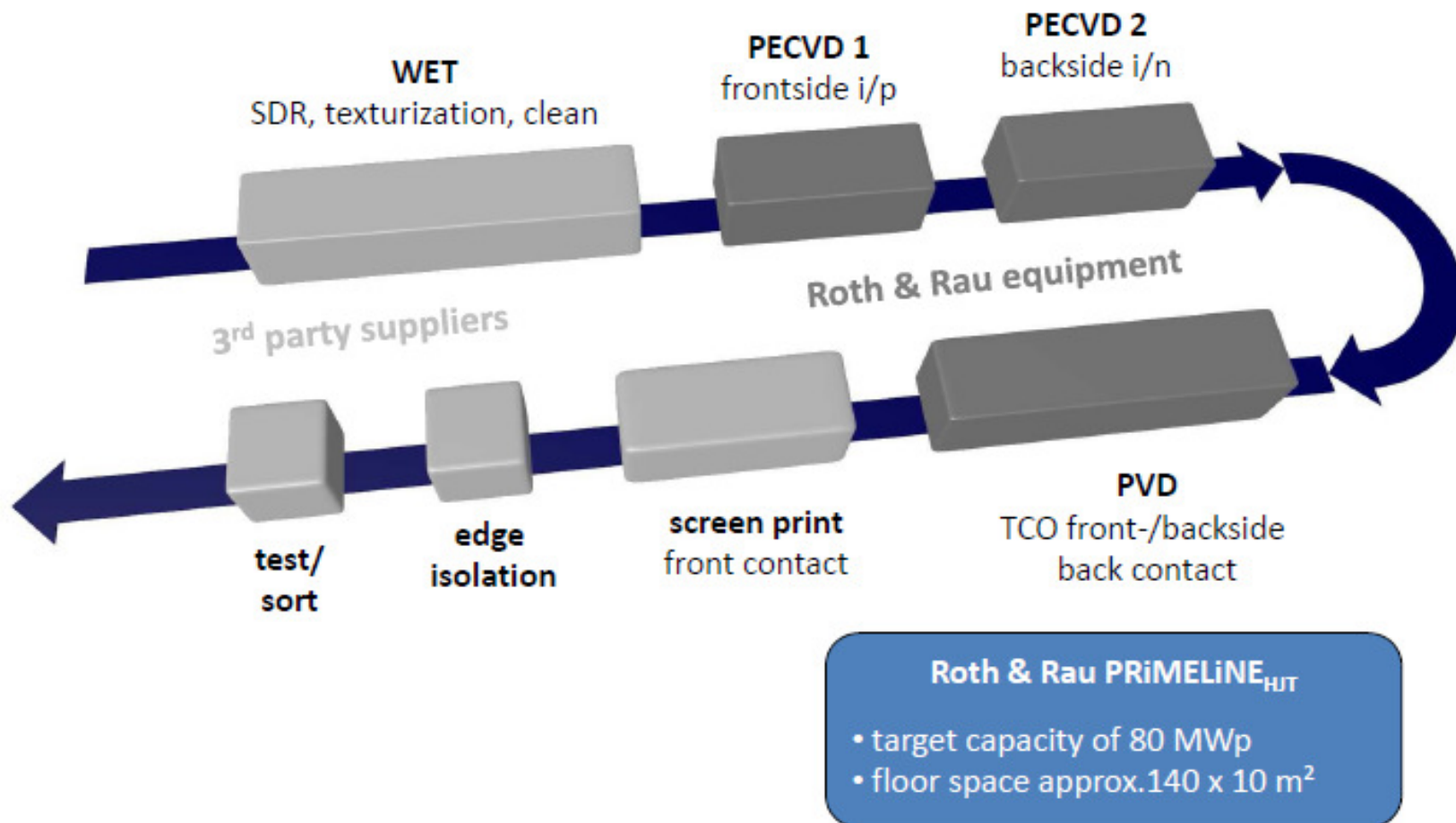
technology know how

manufacturing control (MES software)

Market position of the Roth & Rau group

- market leader
- among TOP 3
- market presence (new products)
- no products

Products and technology for photovoltaic's Heterojunction solar cell production process



What is the meaning of the product name?

SiNA®

Si licon

N itride

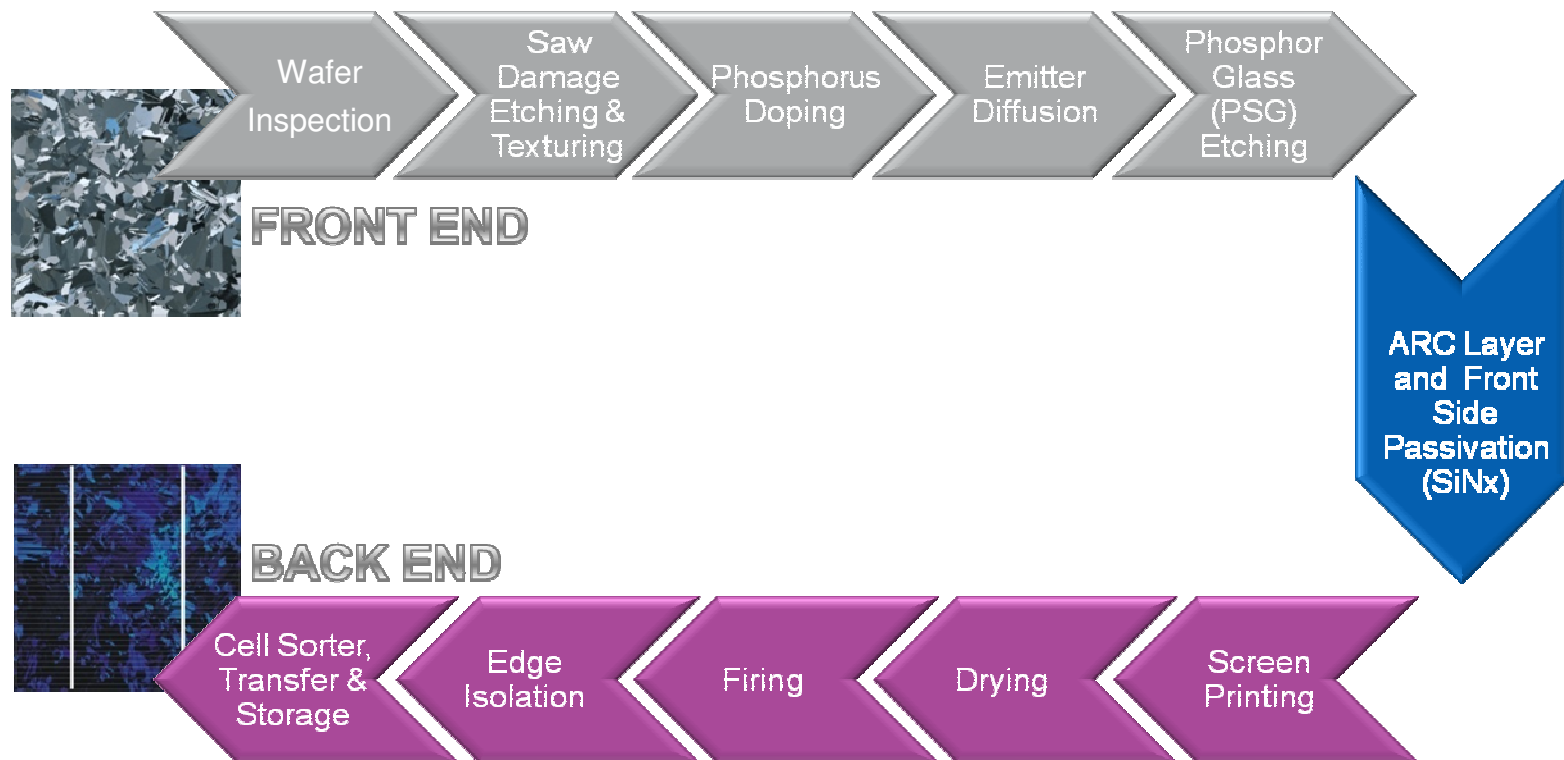
A bscheidung (DE)=
deposition (EN)



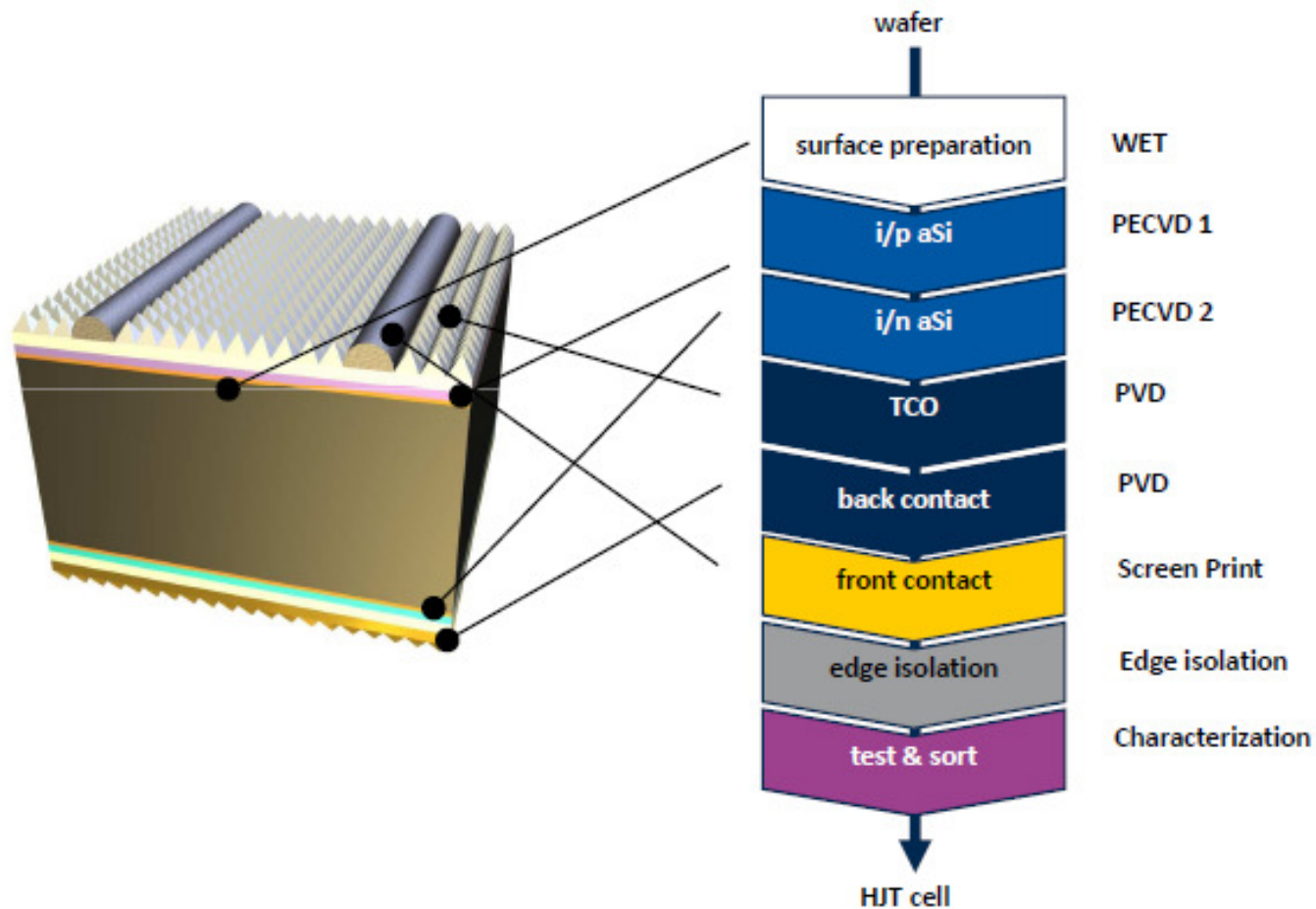
Modular Design offers

HIGHEST Flexibility

C-Si Cell Format & Process Flow



Heterojunction Cell Format



What are the product applications? C-Si

SiNA® & DEP_x

Plasma deposition processes

- Production Level** ■ Si_xN_y
- Si_xO_y - DEP_x

MAiA®

Plasma etch processes

- R&D Level** ■ Texturing
- R&D Level** ■ Saw damage etch (depends on further process requirements)
- Pilot Line Level** ■ Pre-cleaning

Plasma deposition processes

- R&D Level** ■ a-Si
- Production Level** ■ Si_xO_y
- Production Level** ■ $\text{Si}_x\text{O}_y/\text{Si}_x\text{N}_y$
- R&D Level** ■ $\text{Si}_x\text{C}_y\text{N}_z$
- Production Level** ■ Al_xO_y
- Pilot Line Level** ■ $\text{Al}_x\text{O}_y/\text{Si}_x\text{N}_y$
- Pilot Line Level** ■ $\text{Al}_x\text{O}_y/\text{Si}_x\text{O}_y/\text{Si}_x\text{N}_y/\text{Si}_x\text{O}_y\text{N}_z$

What are the product applications? Heterojunction

HELiA PECVD/PVD

PECVD deposition processes

Production Level

- a-Si un Doped (intrinsic)

R&D Level

- a-Si Doped

PVD deposition processes

Production Level

- TCO (ITO)
- Metal (e.g. Al, Ag)



Double Side MAiA® Plasma Process

Best Cell

EFF.: 17,3% !

could be successfully proven
in Roth & Rau R&D pilot line
(Technology Centre)

Efficiency [%]	Uoc [mV]	Isc [A]	FF [%]	Rs [Ω]	Rsh [Ω]
17,29	627	8,63	77,7	0,0039	52,2

Fig1:
Top Efficiency LoBaCo Cell

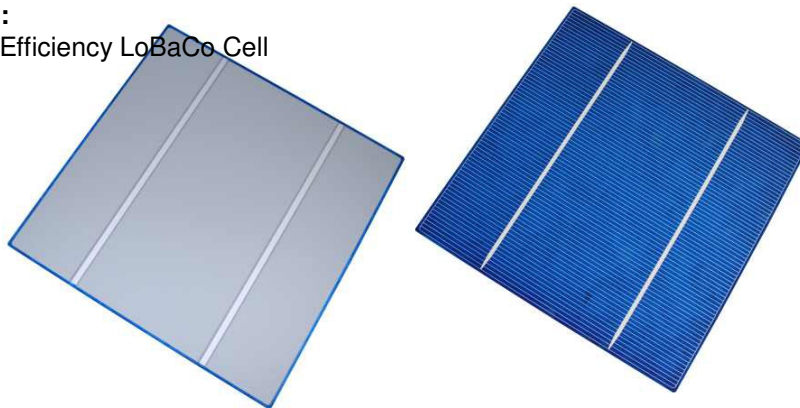
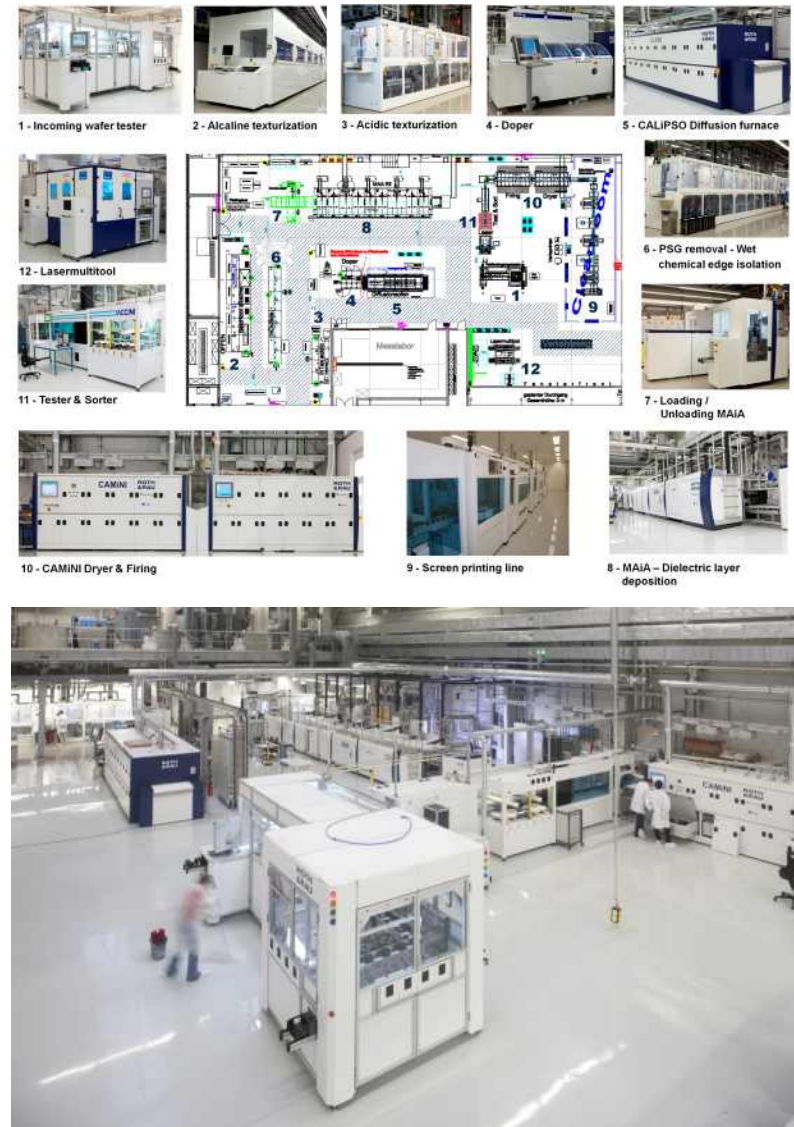
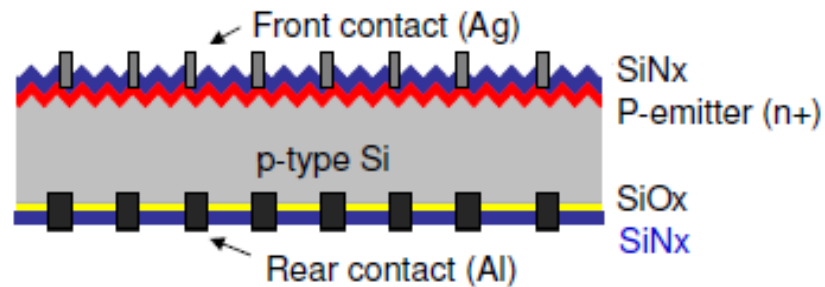


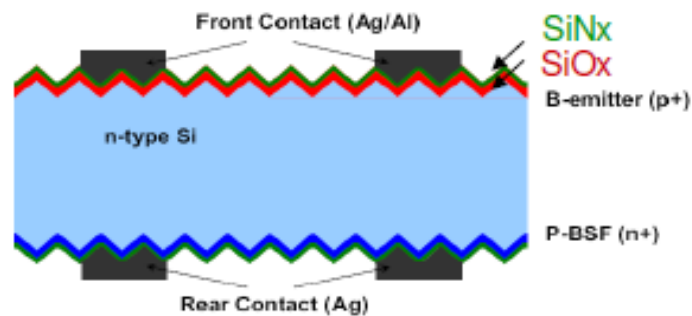
Fig2 (right):
View into the Roth & Rau R&D pilot line



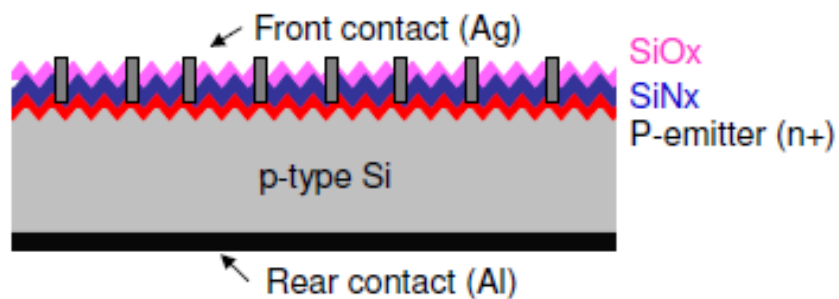
Applications for c-Si wafer processing



- Back side passivation on p-type

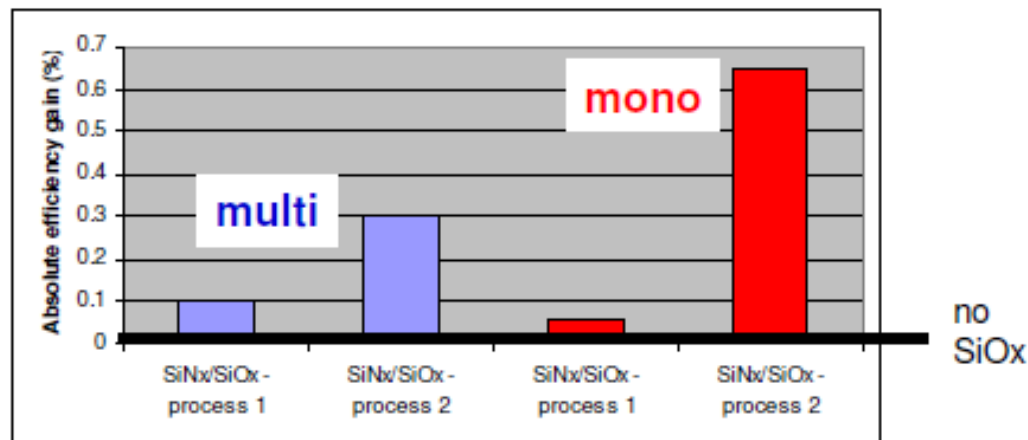
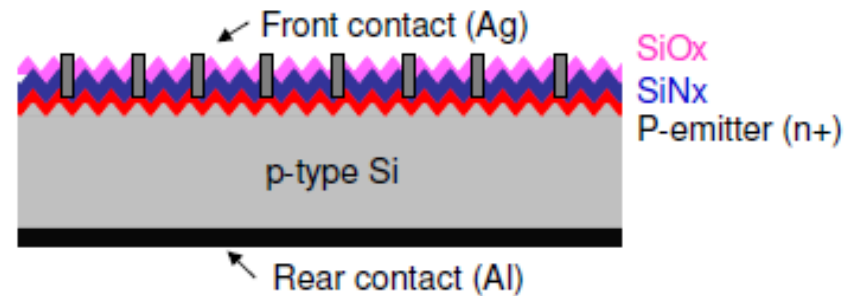


- Passivation of B-emitter on n-type



- Front side optical coating

Applications for c-Si wafer processing



SiNx/SiOx stack

- SiOx layer as front side optical coating
- process improvement by changing to N2O
- significant gain on cell level both on multi and mono wafers

Heterojunction Technology Baseline



- Roth&Rau-research-center in Neuchatel, Switzerland
- Team of 10 physicists and technicians
- Fully equipped research-lab including all manufacturing steps on lab scale
- Close collaboration with EPF Lausanne

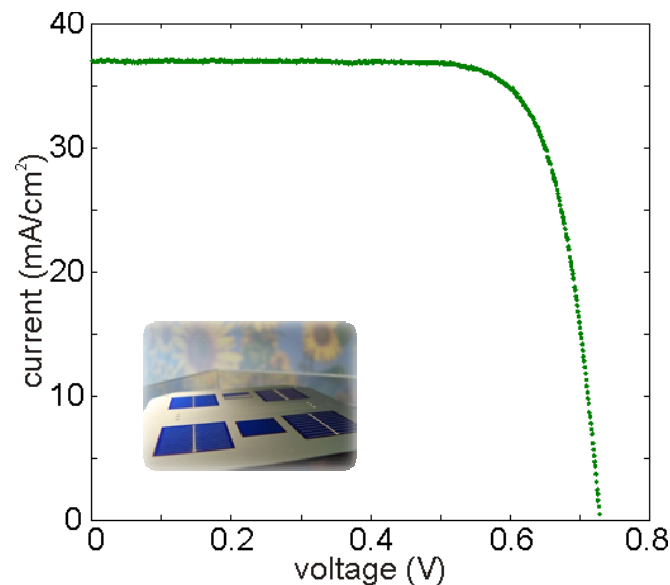
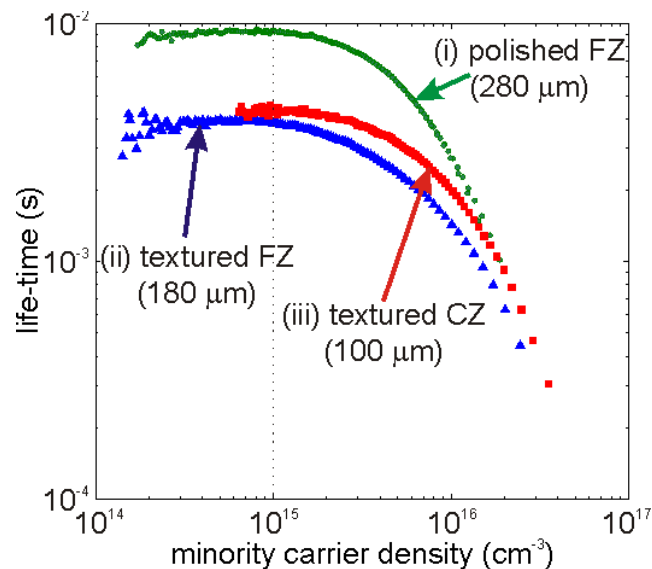
Area (cm ²)	Efficiency (%)	V _{oc} (mV)	FF (%)	I _{sc} (mA/cm ²)
4	21.0	729	77.9	37.0
148	19.3	726	76.6	34.7

results published in September 2010

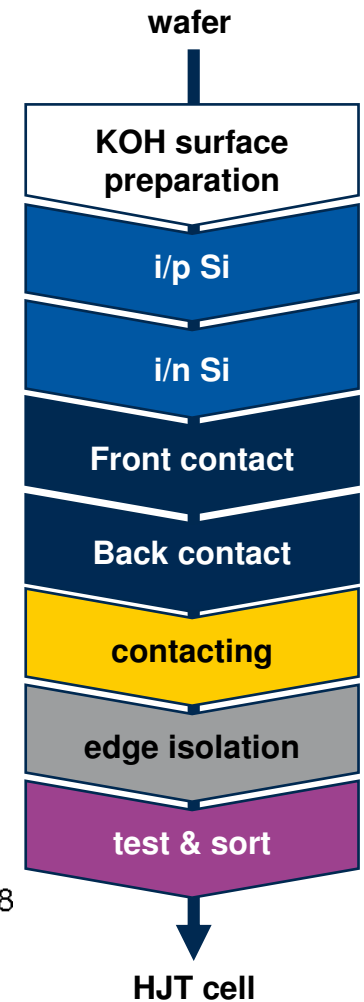
Heterojunction Technology Baseline

HJT Technology status

Proven carrier-lifetime of >6 ms
 Demonstrated cell performance of 21% (4cm²)
 Demonstrated cell performance of 19.3% (wafer)
 (EU PVSEC 2010 Valencia)



(2x2 cm², VOC 7.29mV, FF 77.9%)



SiNA General Design



Modular Construction System

50-120 MWp

SiNA®

Carrier 1860 x 1000 mm
50 - 6" – wafer

Process Module (PM)

with 4 Plasma Sources

with 6 Plasma Sources

Transfer Module

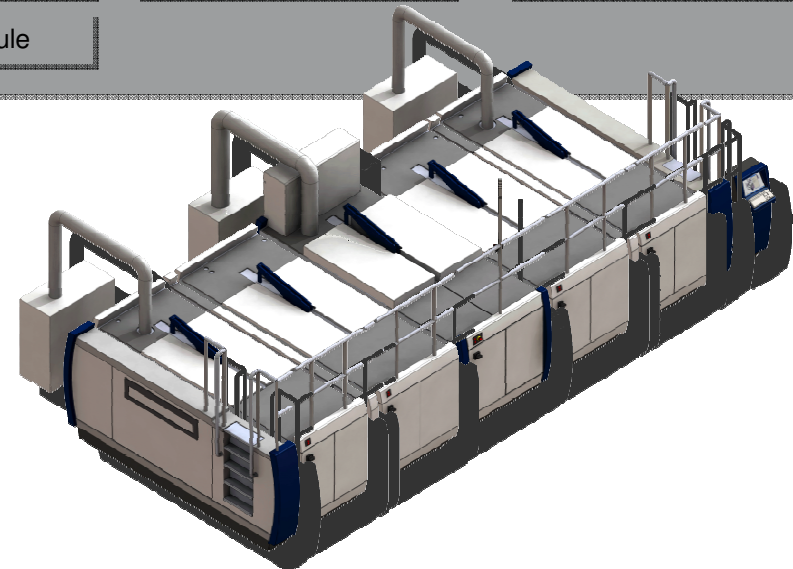
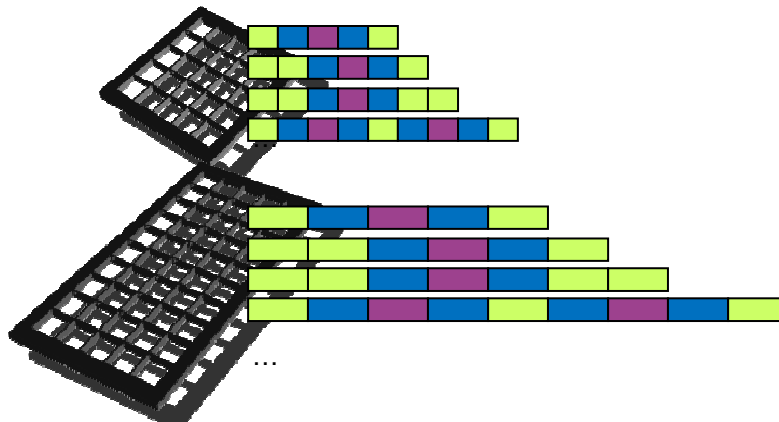
Basic Design

Selection based on technology requirements
Selection of single modules requirements

Main Function

Sub Function

POSSIBLE SYSTEM CONFIGURATION



Overview – Product Types & Sizes

Capacity

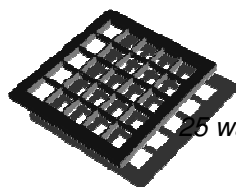
	SINA®1000	SINA®1600	SINA®2000	SINA®2400	SINA®2800	
GROSS wafer TpT ⁽¹⁾ :	1061	1542	1996	2426	2831	[wafers/hour]
NET wafer TpT ⁽¹⁾ :	1014	1472	1900	2302	2683	[wafers/hour]
Wafer size:	125/ 156 /200	125/ 156 /200	125/ 156 /200	125/ 156 /200	125/ 156 /200	[mm]
Wafer thickness:	100...300	100...300	100...300	100...300	100...300	[μm]
MTBF ⁽²⁾ :	450	430	390	350	340	[hour]
MTTR ⁽²⁾ :	2,1	2,5	3,3	4,1	4,3	[hour]
Uptime ⁽²⁾ :	> 95	> 95	> 94	> 93	> 93	[%]
Foot print (LxW) ⁽⁴⁾ :	7,6 x 3,7	7,6 x 3,7	9,6 x 3,7	10,9 x 3,7	10,9 x 3,7	[m]

1) TpT calculated for 6 inch wafers @Tk.=85nm R.I.=2,05 measured on cz-wafer

2) Calculations based on RR field data

3) Excluded scheduled preventive maintenance time.

4) Excluded pump units

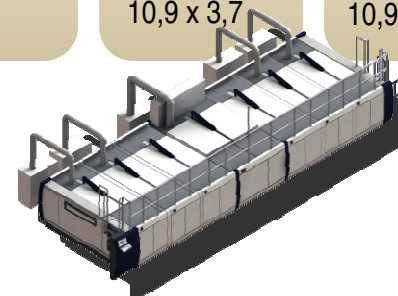


Carrier Capacity:

25 wafers @6"-wafers



**30 MWp
Application**

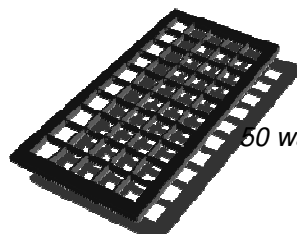


Overview – Product Types & Sizes

Capacity

	SiNA®2200+	SiNA®2600+	SiNA®3200+	SiNA®3600+	SiNA®4000+	
GROSS wafer TpT⁽¹⁾:	2201	2687	3153	3593	4018	[wafers/hour]
NET wafer TpT⁽¹⁾:	2101	2563	3001	3413	3801	[wafers/hour]
Wafer size:	125/ 156 /200	125/ 156 /200	125/ 156 /200	125/ 156 /200	125/ 156 /200	[mm]
Wafer thickness:	100...300	100...300	100...300	100...300	100...300	[μm]
MTBF⁽²⁾:	440	430	390	370	330	[hour]
MTTR⁽²⁾:	2,1	2,5	3,3	4,1	4,3	[hour]
Uptime⁽²⁾:	> 95	> 95	> 94	> 94	>93	[%]
Foot print (LxW)⁽⁴⁾:	11,0 x 3,7	11,6 x 3,7	13,8 x 3,7	14,7 x 3,7	16,9 x 3,7	[m]

- 1) TpT calculated for 6 inch wafers @Tk.=85nm R.I.=2,05 measured on cz-wafer
- 2) Calculations based on RR field data
- 3) Excluded scheduled preventive maintenance time.
- 4) Excluded pump units



Carrier Capacity:
50 wafers @6"-wafers



**60 MWp
Application**



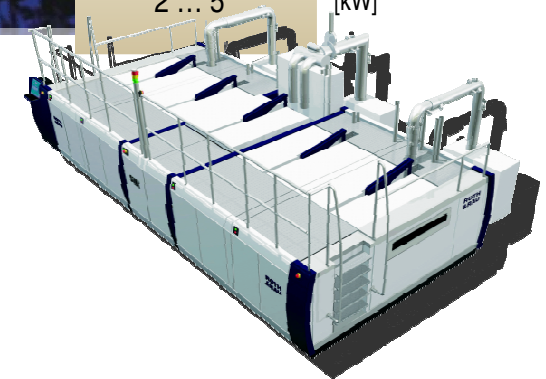
**Highest
PECVD
Troughput in the
PV market**

Overview – Product Types & Sizes

General Specifications

Layer thickness ⁽¹⁾ :	20 ... 200	[nm]	Process gases:	SiH ₄ /NH ₃	
Index of refraction ⁽²⁾ :	1.9 ... 2.3		Process gases total flow ⁽⁴⁾ :	1.0 ... 4.0	[slm]
Layer uniformity ⁽³⁾ :	= (Max-Min)/(Max+Min) x 100%		Gas ratio (Q _{NH3} /Q _{SiH4}):	2.0 ... 3.5	
Tk (p-t-p) spec./typical:	< ± 3.0 / < ± 2.5	[%]	T _{process} :	350 ... 550	[°C]
Tk (w-t-w) spec./typical:	< ± 3.0 / < ± 2.5	[%]	p _{process} ⁽⁵⁾ :	0.1 ... 0.3	[mbar]
Tk (r-t-r) spec./typical:	< ± 3.0 / < ± 2.5	[%]	No. of vacuum chambers:	5...8	
R.I. (p-t-p):	< ± 1.5	[%]	Base pressure:	< 1 x 10 ⁻³	[mbar]
R.I. (w-t-w):	< ± 1.5	[%]	No. of plasma sources:	2 ... 8	
R.I. (r-t-r):	< ± 1.5	[%]	MW Peak power:	2 ... 5	[kW]

- 1) Impact on TpT (typical: tk=85nm).
- 2) Impact on TpT (typical: R.I.=2,05).
- 3) Depends on measurement layout. The measurement layout ist attached in RR-Process-Spec.
- 4) Depends on No. of plasma sources
- 5) Impact on TpT.





Automation



Confidential

Features

- RR own automation for all SiNA® & MAiA® applications (“all from one single source”) → defined system with defined interfaces
- Non robot solution → Less stress on wafer through belt drives → back side handling for face up deposition
- Configuration as single or double end solution according customer requirements based on a modular concept
- Compact design (small footprint)...

Benefits

LESS wafer stress

LESS wafer breakage

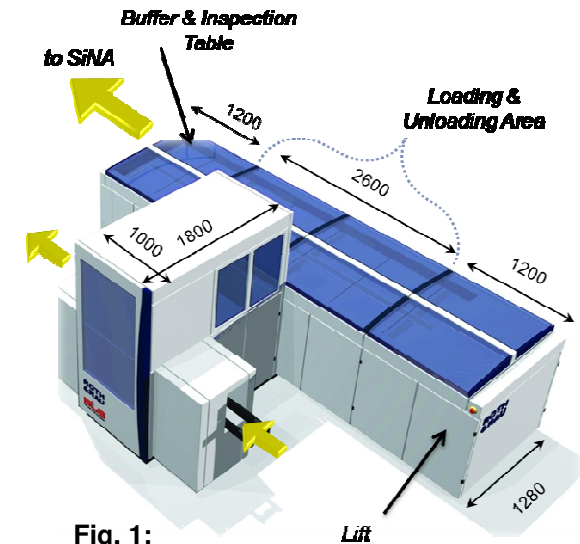


Fig. 1:
single end automation, i.e. loader
(footprint ~2m² + 5m² carrier handling)

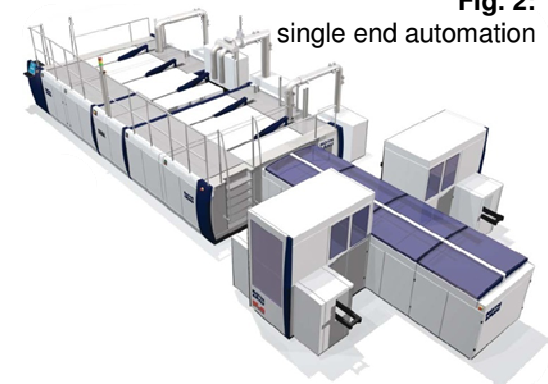


Fig. 2:
single end automation

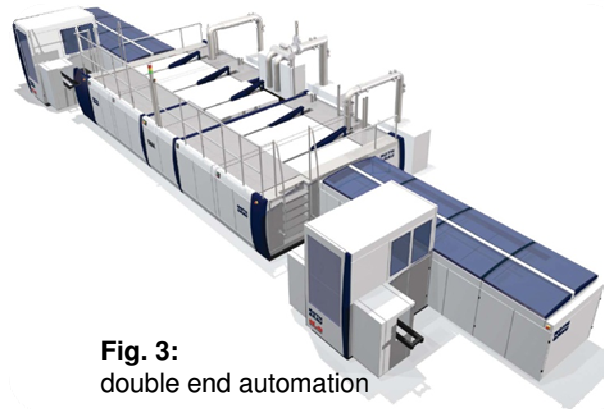


Fig. 3:
double end automation



Confidential

Summary Benefits New SiNA®

- Highest flexibility in terms of throughput and process by modular design
- Highest throughput (4000wph and more)
- Excellent layer uniformity (+/-3%)
- High Uptime (>95%)
- High Yield (>99%)
- Higher process temperature (up to 550°C) and good thermal uniformity (+/-4%)
- 40% smaller total footprint compared with the forerunner model
- Low Operating Cost
- Low CoO (0,008€/Wp)
- Best Safety, Quality & Design



Modular Design



Increased TpT



Reduced TCoO

SiNA® 1600



made
in
Germany

HIGHEST Flexibility

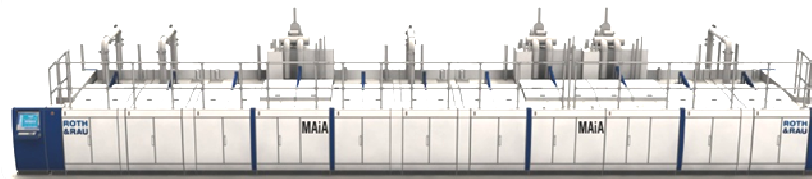
BEST Throughput

BEST TCoO

What is the meaning of the product name?

MAiA®

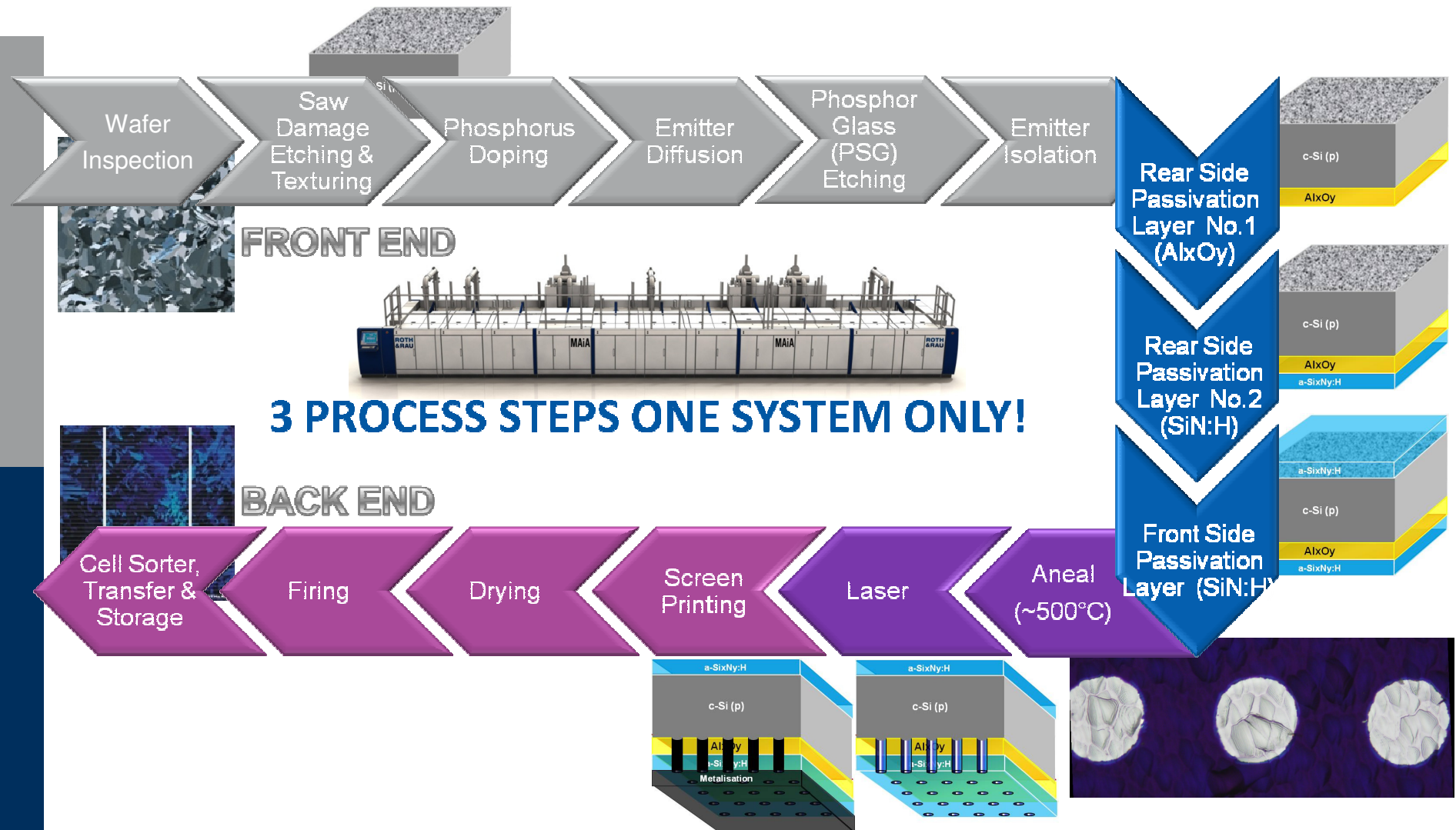
Multiple
Application
inline
Apperatus (Latin) = Equipment (EN)



Modular Design offers HIGHEST Flexibility


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Double Side MAiA® Plasma Process



Al₂O₃–PE CVD for backside passivation

PERC cell Passivation -> Front ARC + RS AlO_x/SiN Stack

as “all in one” low cost solution for 3x dielectric coatings in just 1x pass through on MAiA inline tool with upto 3600 wph .

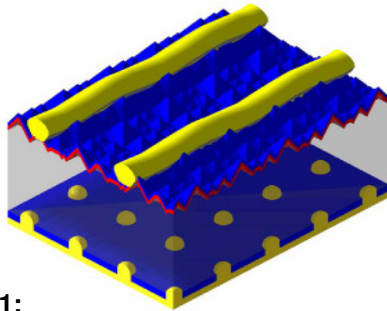
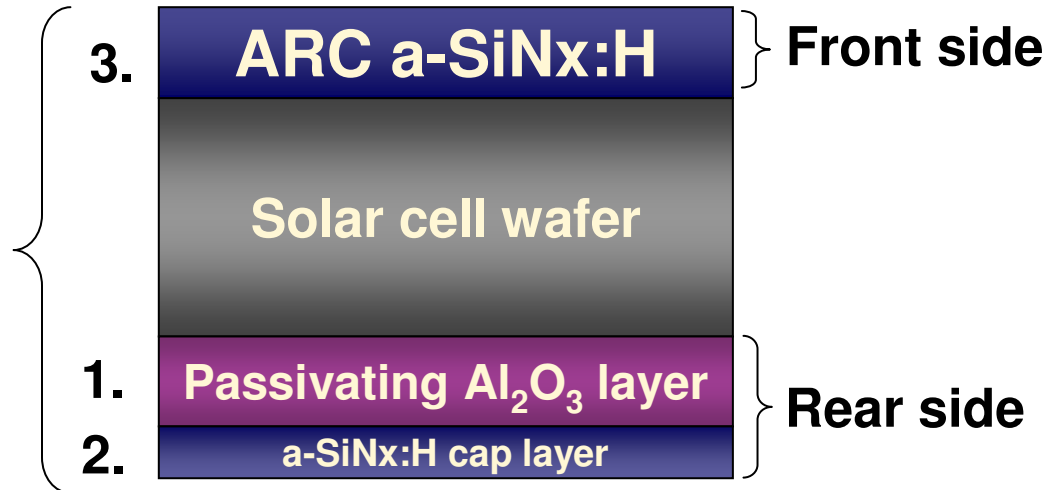


Fig1:
PERC-type solar cell structure used to demonstrate the applicability of an Al₂O₃ rear surface passivation to high-efficiency solar cells.

Source:
23rd European Photovoltaic Solar Energy Conference



expected Efficiency gain up to + 1%

- **Surface field passivation** to high negative fix charges in Al₂O₃ after anneal + firing
- **Improved IQE for red photons** with optimized SiN cap layer

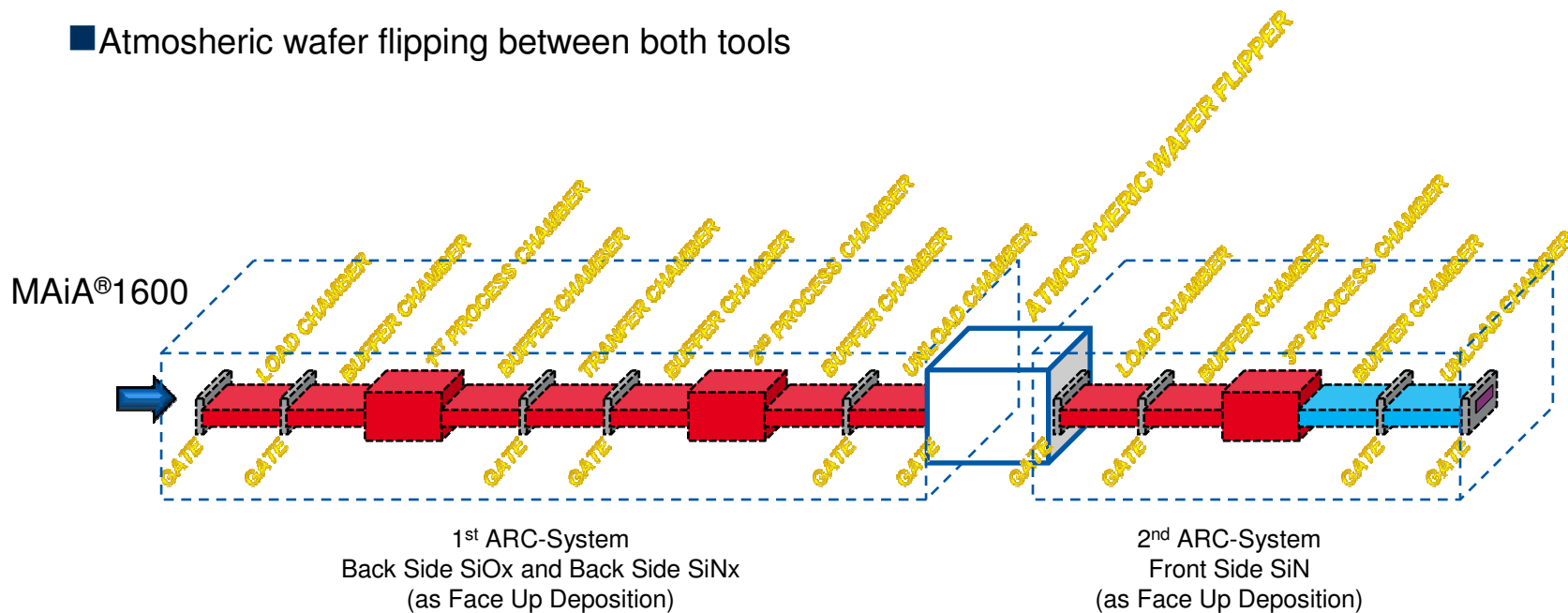
Double Side MAiA® Deposition Concepts

1st Generation



MAiA Front - Front Concept:

- separate tools for front side and for backside processing,
- only use of top down plasma processes (good layer uniformity),
- Atmospheric wafer flipping between both tools



Double Side MAiA® Deposition Concepts

2nd Generation

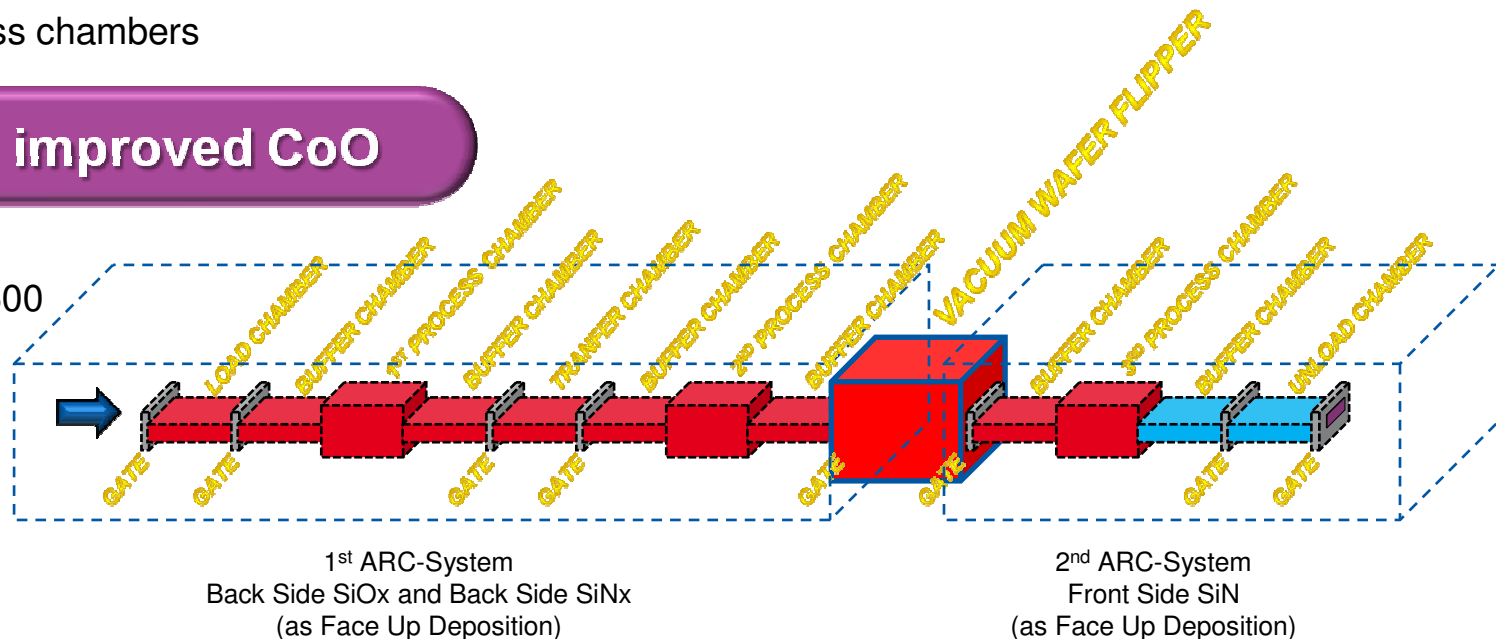
MAiA Front - Front Concept:

- separate tools for front side and for backside processing, but without vacuum and thermal disruption
- Vacuum wafer flipping between both tools
- Less chambers



improved CoO

MAiA®1600

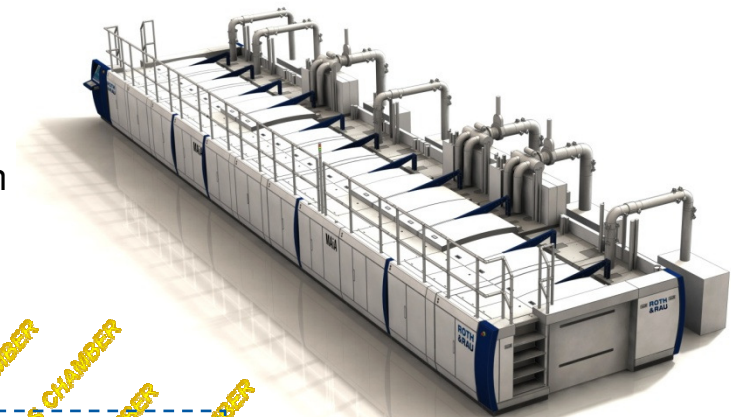


Double Side MAiA® Deposition Concepts

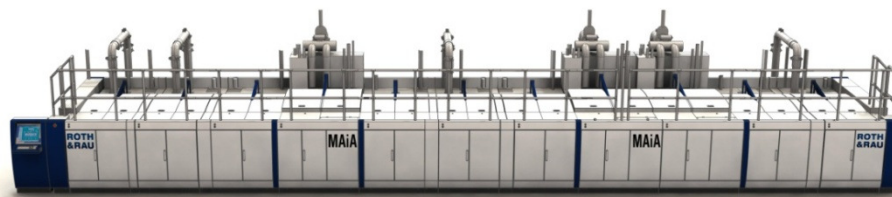
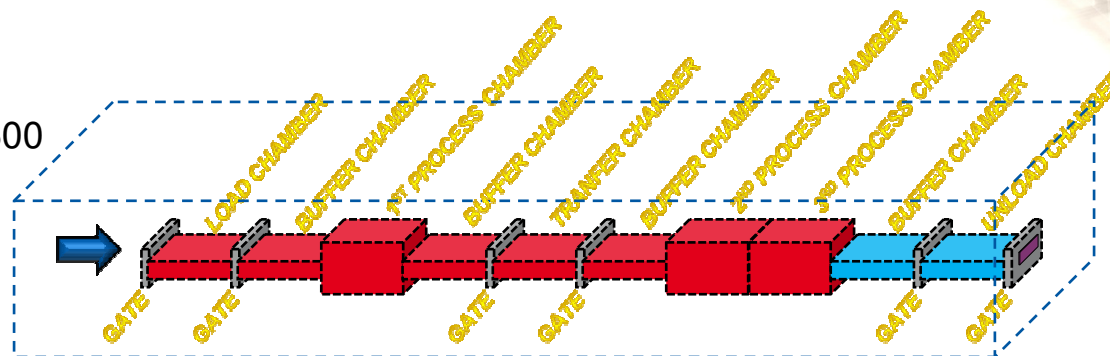
3rd Generation

MAiA Front - Back Concept:

- **ONE** tool for front side and for backside processing,
- NO vacuum and thermal disruption → less chambers
- NO wafer flipping necessary → NO mechanical stress on wafer material



MAiA®1600



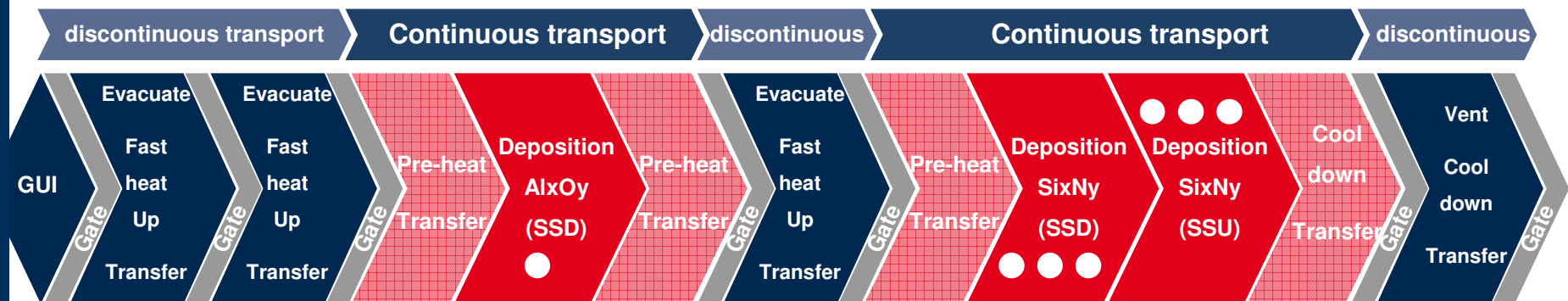
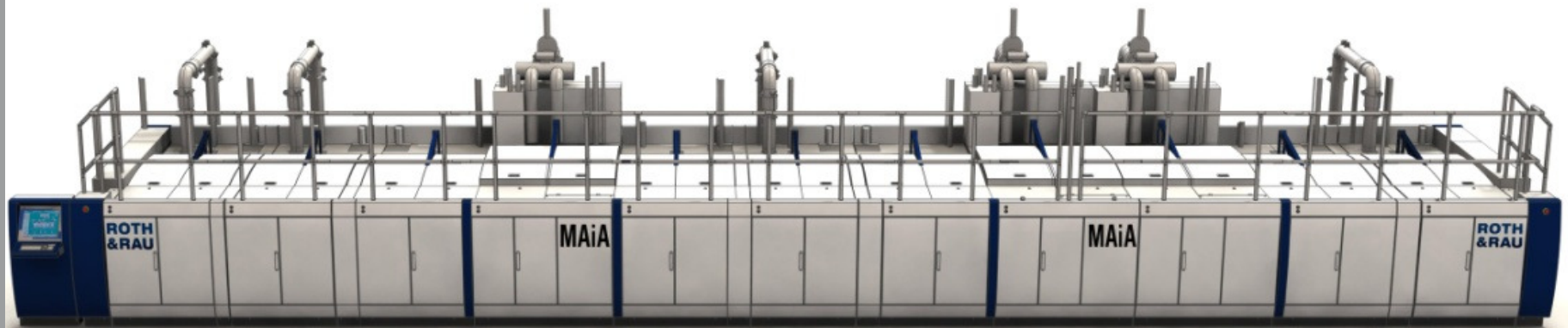
ONE ARC-System
Back Side SiO_x and Back Side SiN_x
(as Face Down Deposition) &
Front Side SiN
(as Face Up Deposition)

BEST CoO

**ROTH
&RAU**

Double Side MAiA® Plasma Process

ALL IN ONE



The new generation of MAiA® - Summary

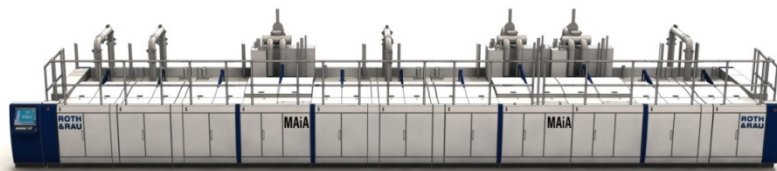
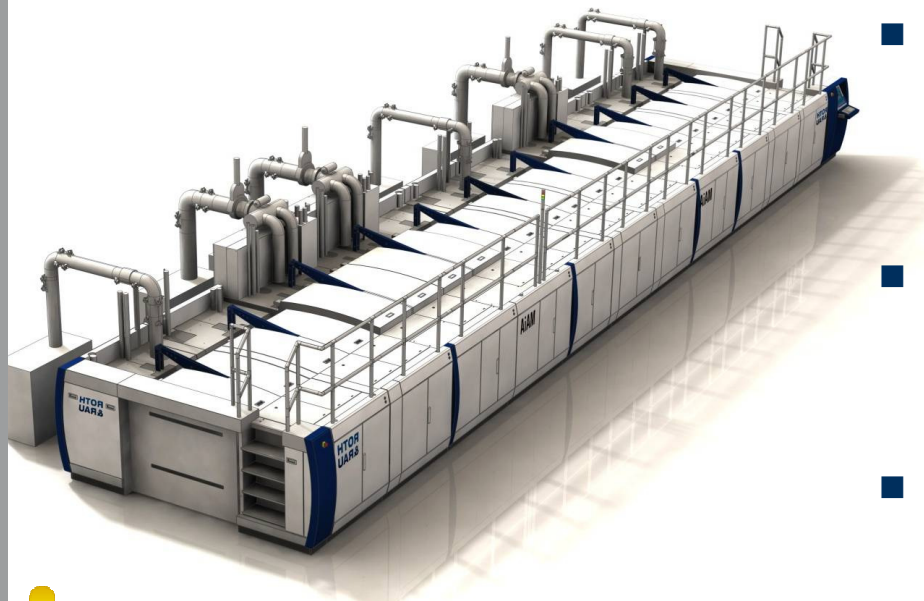


Fig. 1:
MAiA 1600 (11 chamber)



- High performed modular plasma equipment system based on SiNA platform with:

HIGHEST Flexibility

BEST Throughput

BEST CoO

- MAiA´s combines PE-CVD for SiN-front and dielectric layer systems for backside (SiOx/SiNx or AlOx/SiNx) in one tool as the unique PV supplier

3 process steps ONE system only!

- SiOx/SiN process for backside passivation successfully placed on the market,

Front & Back Side ARC in ONE Step

- new AlOx-process for high efficient solar cell concepts as stand-alone or in combination with cap layer available with superiour results,

! Comparable or better to SEMI proven ALD process in Cell Efficiency at higher throughput and lower costs !

**ROTH
&RAU**

PRiME-LiNE_{HJT} HELiA PECVD Tool Layout





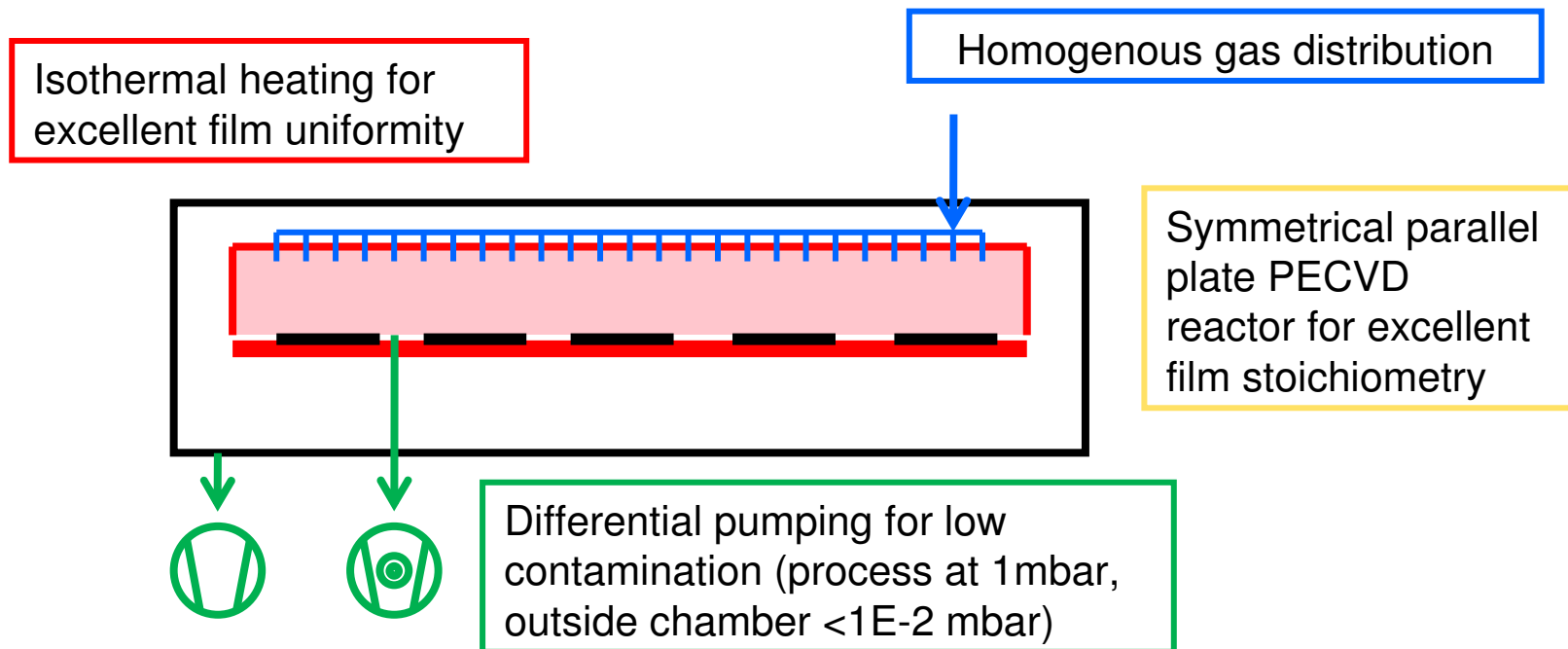
PRiME-LiNE_{HJT} HELiA PECVD Deposition System

- Superior patented S-Cube Reactor for high quality a-Si:H deposition
 - Low contamination with Box-in-box reactor
 - Isothermal heating for good uniformity
 - Narrow gap electrode, symmetrical
- Carrier-less wafer handling for contamination-free processing
- High throughput of 2400 wph for i/p or i/n
 - Flexible design to accommodate 1000 – 2400 wph
- Deposition of intrinsic, p-doped or n-doped a-Si:H possible

**Excellent passivation quality of a-Si – layers
(carrier lifetime > 6ms)**

PRiME-LiNE_{HJT} HELiA PECVD Production System

- Patented S-Cube™ PECVD process system for high performance a-Si:H deposition
- Advanced, carrier-less wafer handling system for contamination-free transfer of substrates



**ROTH
&RAU**

PRiME-LiNE_{HJT} HELiA PVD Production Tool configuration





PRiME-LiNE_{HJT} HELiA PVD Production System

High-performance PVD Solution with rotary magnetrons:

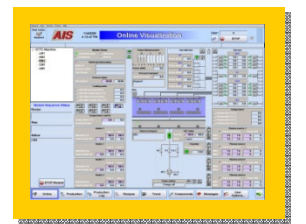
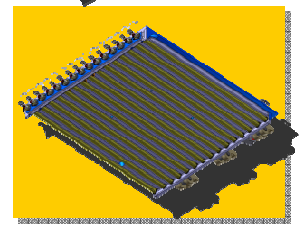
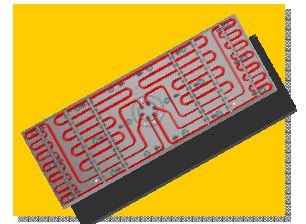
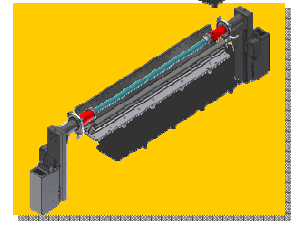
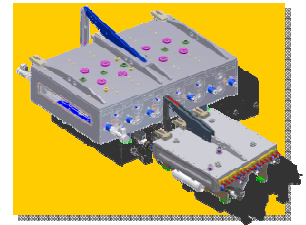
- Proven high quality TCO and metal deposition in R&D line and pilot tool
- Lowest COO: Low material cost with rotary magnetrons (>90% Target util.)
- Tact time of PECVD tool – simple handling interface
- Capability of front and back deposition in same tool (2400 wph)
- Excellent uniformity with rotary linear magnetrons
- Long MTBM with multiple magnetrons for front and back side deposition



Benefits HELiA PECVD/PVD

- Competence in HJT – Full R&D line and Commercially Available Deposition Systems
- Superior PECVD Solution with S-Cube, carrier-less wafer handling
 - Superior passivation quality
 - Flexible design for throughput up to 2400 gross WPH
- PVD: Excellent process conditions and CoO advantage with rotary magnetron sources
 - Option for 2 or 3 back metal deposition sources and processes
- Access to R&D line, full qualification of PECVD and PVD tools in pilot line format at Roth & Rau HQ, Hohenstein Germany

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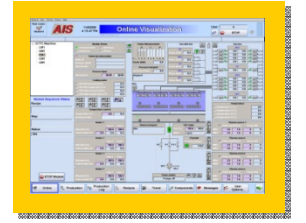
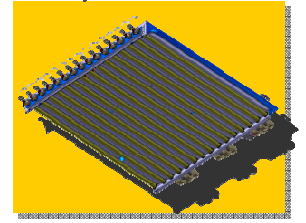
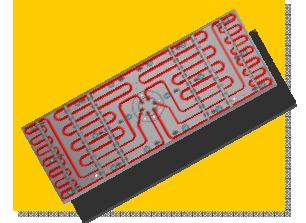
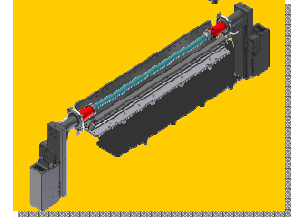
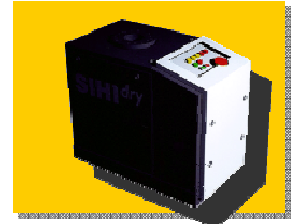
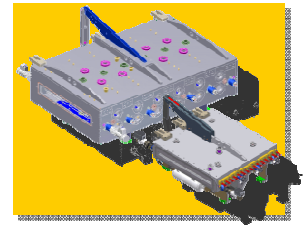


Conclusions

- Market Leader in PECVD, PVD Deposition Equipment and Process Technology
- Large Process base
- Single and multi process application
- Multi cell format base
- Focus on enhanced Cell efficiency process and equipment solutions
- Positioned for short term and long term success

How can we help?

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**ROTH
&RAU**

www.roth-rau.com

Roth & Rau USA

+ 1 614 481 6701

Roth & Rau AG
An der Baumschule 6-8
09337 Hohenstein-Ernstthal
Germany

☎ +49 (0) 3723 6685-0
Fax +49 (0) 3723 6685-100
e-mail: info@roth-rau.com



Thank you for your attention.